



RADIO TEST REPORT

Test Report No. : 29BE0211-HO-01-A-R1

Applicant : KYOCERA Corporation
Type of Equipment : iBurst User Terminal USB type
Model No. : UTU03-1890F-US-A
Test regulation : FCC Part 24 2005
FCC ID : JOYIUU19AC
Test Result : Complied

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
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6. Original test report number of this report is 29BE0211-HO-01-A.

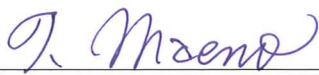
Date of test: October 6 to November 10, 2008

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SECTION 1: Customer information

Company Name : KYOCERA Corporation
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Contact Person : Akira Namba

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : iBurst User Terminal USB type
Model No. : UTU03-1890F-US-A
Serial No. : No.18
Rating : DC 5V (from USB interface)
(PC's input: AC 120V / 60Hz)
Receipt Date of Sample : October 3, 2008
Country of Manufacture : Japan
Condition of EUT : Engineering prototype
(Not for Sale: This sample is not mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

Model No.: UTU03-1890F-US-A (referred to as the EUT in this report) is iBurst User Terminal USB type.

Equipment Type : Transceiver
Frequency Range : 1890MHz to 1910MHz
Frequency operation : 1890.3125MHz to 1909.6875MHz
Type of modulation : BPSK, BPSK+, QPSK, QPSK+, 8PSK, 8PSK+, 12QAM, 16QAM
Bandwidth : 500kHz
Channel spacing : 625kHz
Intermediate Frequency : 340kHz
Antenna Type : Extensible Helical Antenna
Antenna Gain : 2.9dBi (max)
Other Clock Frequency : 144MHz, 24MHz, 18MHz, 9MHz, 6MHz, 32.768kHz
Operating voltage (Inner) : DC 5V
Temperature of operation : 0 deg. C. to + 40 deg. C.

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 24 2005, final revised on October 20, 2005

Title : FCC 47CFR Part 24
Personal Communications Services

3.2 Procedures and results

| Item | Test Method | FCC Regulations | Remarks | Deviation | Worst margin | Results |
|--|----------------------------------|---------------------------|------------------------|-----------|---|----------|
| Output Power | Section 2.1046 | Section 24.232(c) | Conducted/ Radiated | N/A | [Radiated] 4.4dB, PK, 1899.6875MHz, Horizontal | Complied |
| Emission Bandwidth, 99% Occupied Bandwidth | Section 2.1049 | Section 24.238(b) | Conducted | N/A | - | Complied |
| Band-Edge | Section 2.1049 | Section 24.238(a), (b) | Conducted/ Radiated | N/A | [Radiated] 0.7dB, 1890MHz, Vertical | Complied |
| Spurious Emission (Conducted) | Section 2.1051 | Section 24.238(a) | Conducted | N/A | - | Complied |
| Spurious Emission (Radiated) | Section 2.1053 | Section 24.238(a) | Radiated | N/A | 8.8dB 13232.19MHz Horizontal | Complied |
| Frequency Stability (Temperature Variation) | Section 2.1055(a) (1) and (b) | Section 24.235 | Conducted | N/A | - | Complied |
| Frequency Stability (Voltage Variation) | Section 2.1055(d)(1) and (2) | Section 24.235 | Conducted | N/A | - | Complied |

Note: UL Japan, Inc.'s EMI Work Procedures No. QPM05

*These tests were also referred to TIA-603-C "Land Mobile FM or PM Communications Equipment Measurement and Performance Standards."

*These tests were performed without any deviations from test procedure except for additions or exclusions.

3.3 Confirmation

UL Japan, Inc. hereby confirms that E.U.T., in the configuration tested, complies with the specifications FCC Part 24.

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3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Radiated emission tests (Output Power, Band-Edge, Spurious Emission)

The measurement uncertainty for this test is 4.62dB(30-1000MHz) and 5.06dB(Above 1GHz).

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

Antenna terminal conducted tests (Output Power, Band-Edge, Spurious Emission)

The measurement uncertainty for this test is 1.0dB.

Frequency tests (Bandwidth, Frequency Stability)

The measurement uncertainty for this test is 1×10^{-5} .

3.5 Test Location

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| | FCC Registration Number | IC Registration Number | Width x Depth x Height (m) | Size of reference ground plane (m) / horizontal conducting plane | Other rooms |
|-------------------------------|-------------------------------|---------------------------|-------------------------------|--|-----------------------------|
| No.1 semi-anechoic chamber | 313583 | 2973C-1 | 19.2 x 11.2 x 7.7m | 7.0 x 6.0m | No.1 Power source room |
| No.2 semi-anechoic chamber | 655103 | 2973C-2 | 7.5 x 5.8 x 5.2m | 4.0 x 4.0m | - |
| No.3 semi-anechoic chamber | 148738 | 2973C-3 | 12.0 x 8.5 x 5.9m | 6.8 x 5.75m | No.3 Preparation room |
| No.3 shielded room | - | - | 4.0 x 6.0 x 2.7m | N/A | - |
| No.4 semi-anechoic chamber | 134570 | 2973C-4 | 12.0 x 8.5 x 5.9m | 6.8 x 5.75m | No.4 Preparation room |
| No.4 shielded room | - | - | 4.0 x 6.0 x 2.7m | N/A | - |
| No.5 semi-anechoic chamber | - | - | 6.0 x 6.0 x 3.9m | 6.0 x 6.0m | - |
| No.6 shielded room | - | - | 4.0 x 4.5 x 2.7m | 4.75 x 5.4 m | - |
| No.6 measurement room | - | - | 4.75 x 5.4 x 3.0m | 4.75 x 4.15 m | - |
| No.7 shielded room | - | - | 4.7 x 7.5 x 2.7m | 4.7 x 7.5m | - |
| No.8 measurement room | - | - | 3.1 x 5.0 x 2.7m | N/A | - |
| No.9 measurement room | - | - | 8.0 x 4.5 x 2.8m | 2.0 x 2.0m | - |
| No.10 measurement room | - | - | 2.6 x 2.8 x 2.5m | 2.4 x 2.4m | - |
| No.11 measurement room | - | - | 3.1 x 3.4 x 3.0m | 2.4 x 3.4m | - |

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Test instruments and Data of EMI

Refer to APPENDIX 1 to 3.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

The mode is used :

- 1) Transmitting mode for Bandwidth tests: Modulation 4 *1
- 2) Transmitting mode for Bandedge(Radiated) tests: Modulation 3 (1890MHz) / Modulation 0 (1910MHz) *1
- 3) Transmitting mode for except Bandwidth and Bandedge tests: Modulation 7 *1
- 4) Transmitting mode for Bandedge(Conducted) tests: Modulation 0 to 7

*1: Modulation

| Modulation Class | Method |
|------------------|--------|
| Modulation 0 | BPSK |
| Modulation 1 | BPSK+ |
| Modulation 2 | QPSK |
| Modulation 3 | QPSK+ |
| Modulation 4 | 8PSK |
| Modulation 5 | 8PSK+ |
| Modulation 6 | 12QAM |
| Modulation 7 | 16QAM |

(Bandedge (1910MHz) worst) Refer to p.20

(Bandedge (1890MHz) worst) Refer to p.20
(Bandwidth worst) Refer to p.19

(Output Power worst) Refer to p.14

The worst modulation of Bandwidth decided from what had the widest bandwidth in the modulation 0 to 7.

The worst modulation of Bandedge decided from what had the highest bandedge level in the modulation 0 to 7.

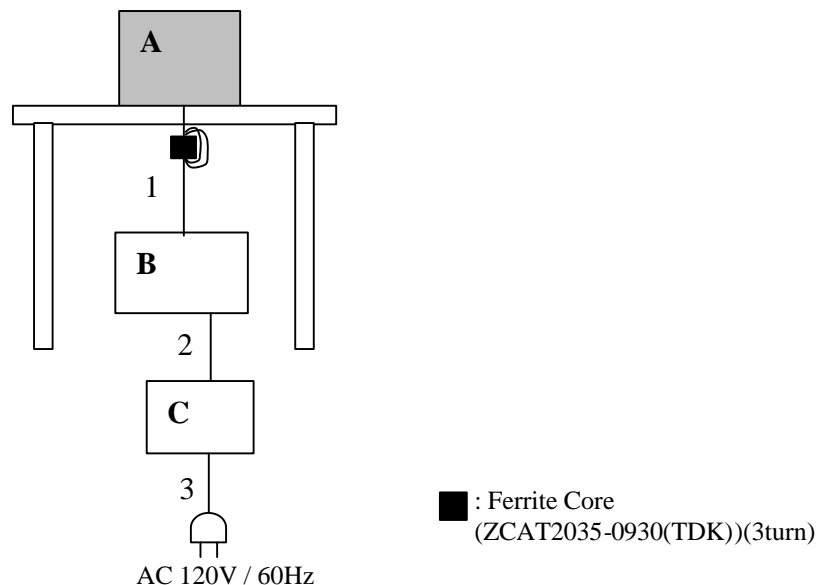
The worst modulation of Output Power decided from what had the highest Output power level in the modulation 0 to 7.

It used worst data stream in normal communication mode for all tests. Refer to p.16.

1 data frame structure is 3 slots (545usec./slot) in 5msec in every time.

Justification: The system was configured in typical fashion (as a customer would normally use it) for testing.

4.2 Configuration and peripherals



* Cabling and setup were taken into consideration and test data was taken under worst case conditions.

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Description of EUT and Support equipment

| No. | Item | Model number | Serial number | Manufacturer | Remarks |
|-----|-------------------------------|------------------|---------------|---------------------|---------|
| A | iBurst User Terminal USB type | UTU03-1890F-US-A | No.18 | KYOCERA Corporation | EUT |
| B | Note PC | FMV-780MT5 | R4400146 | Fujitsu | - |
| C | AC Adapter | FMV-AC311S | 747424B | Fujitsu | - |

List of cables used

| No. | Name | Length (m) | Shield | | Remarks |
|-----|-----------|------------|------------|------------|--|
| | | | Cable | Connector | |
| 1 | USB Cable | 0.8 | Shielded | Shielded | with Ferrite Core (EUT) (ZCAT2035-0930(TDK) (3 turn)) |
| 2 | DC Cable | 1.8 | Unshielded | Unshielded | - |
| 3 | AC Cable | 2.0 | Unshielded | Unshielded | - |

SECTION 5: Output Power, Spurious emission and Band-Edge (Conducted/Radiated)

[Conducted]

Test Procedure

The output power (conducted) was measured with a power meter, and an attenuator was connected with the antenna port. The Spurious emission and Band-Edge (conducted) was measured with a spectrum analyzer, and an attenuator was connected with the antenna port.

| | | |
|-------------|---|------------|
| Test data | : | APPENDIX 2 |
| Test result | : | Pass |

[Radiated]

Test Procedure

- 1) EUT was placed on a urethane platform of nominal size, 0.5m by 1.0m, raised 80cm above the conducting ground plane. Test was made with the antenna positioned in both the horizontal and vertical planes of polarization.
The Radiated Electric Field Strength intensity has been measured in a semi anechoic chamber with a ground plane and at a distance of 3m.
The measuring antenna height was varied between 1 to 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.
- 2) Exchanged the EUT to the Substitution Antenna, the measurement was set for the same height as the EUT. The frequency below 1GHz of the Substitution Antenna was used as the Half wave dipole Antenna, which is harmonized with the measured frequency in 1).
The frequency above 1GHz of the Substitution Antenna was used with Horn Antenna.
The Substitution Antenna was connected with the Signal Generator, and the polarized electromagnetic radiation of the Substitution Antenna was matched with the one of the measuring Antenna, which was set with the Signal Generator to the measured frequency in 1). Then, we set with the Output power (CW) of the Signal Generator where the measuring electromagnetic field is equal to the measured value in 1).
The measuring antenna height varied between 1 and 4m to obtain the maximum receiving level.
Its Output power of Signal Generator was recorded.
- 3) Effective radiated power was calculated by subtracting the cable loss and the attenuator loss connected between the Signal Generator and the Substitution Antenna from the Output power of the Signal Generator recorded in 2).
For the usage of the Antenna (Horn Antenna) except for the Half wave dipole Antenna (2.15dBi) for the Substitution Antenna, the Equivalent isotropic radiated power was calculated by compensating the finite difference in the Antenna gain of the isotropic Antenna (Antenna gain: 0dBi), and Substitution Antenna.

- The carrier level and noise levels were confirmed at each position of X and Y axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.
- The carrier level and noise levels were confirmed at each position of 0deg., 90deg. and 180 deg. axes of EUT's antenna to see the position of maximum noise, and the test was made at the position that has the maximum noise.

| | | |
|-------------|---|------------|
| Test data | : | APPENDIX 2 |
| Test result | : | Pass |

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SECTION 6: Bandwidth (Conducted)

Test Procedure

The Emission Bandwidth and 99% Occupied Bandwidth was measured with a spectrum analyzer, and an attenuator was connected with the antenna port.

| | | |
|-------------|---|------------|
| Test data | : | APPENDIX 2 |
| Test result | : | Pass |

SECTION 7: Frequency Stability (Conducted)

Test Procedure

The Frequency Stability was measured with a Vector Signal Analyzer (89441A (HP) (MRENT-72)), and an attenuator was connected with the antenna port.

The Frequency Drift was measured with variation of ambient temperature from -30 to +50 deg.C. at the intervals of 10 deg.C., and also with variation of primary supply voltage from 85 to 115 % of the nominal voltage (102V, 120V, and 138V). The result is shown in ppm unit.

| | | |
|-------------|---|------------|
| Test data | : | APPENDIX 2 |
| Test result | : | Pass |

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